Search Notes

Application/Control	No.

10526162

Applicant(s)/Patent Under Reexamination

MATSUDA ET AL.

HENOK G HEYI

Art Unit

Examiner

2627

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES		
Search Notes	Date	Examiner
Searched EAST, specifically 369/275.1, 275.2, 275.3 and 275.4 (text search only - please see search history printout).	8/13/2008	НН

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/HENOK G HEYI/ Examiner.Art Unit 2627	

U.S. Patent and Trademark Office Part of Paper No.: 20080701